

TRANSMITTAL FORM <i>(to be used for all correspondence after initial filing)</i>		Application Number	10/501,276
		Filing Date	July 9, 2004
		First Named Inventor	Johannes F. de Boer et al.
		Art Unit	2857
		Examiner Name	To be determined
		Total Number of Pages in This Submission	1
		Attorney Docket Number	036115/US - 475387-00016

ENCLOSURES (Check all that apply)		
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SIGNATURE OF APPLICANT, ATTORNEY, OR AGENT	
Firm or Individual name	DORSEY & WHITNEY, LLP Gary Abelev, Esq. (Reg No. 40,479)
Signature	
Date	August 16, 2005

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036115/US/2 – 475387-00016 PATENT

UNITED STATES PATENT AND TRADEMARK OFFICE

Inventor(s) : Johannes F. de Boer et al.
Serial No. : 10/501,276
Filed : July 9, 2004
Entitled : APPARATUS AND METHOD FOR RANGING AND NOISE REDUCTION OF LOW COHERENCE INTERFEROMETRY LCI AND OPTICAL COHERENCE TOMOGRAPHY OCT SIGNALS BY PARALLEL DETECTION OF SPECTRAL BANDS
Group Art Unit : 2857
Examiner : To be assigned

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Commissioner for Patents
P.O. Box 1450
Alexandria, Virginia 22313-1450

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(Signature)

Dear Sir:

Pursuant to 37 C.F.R. §§ 1.56 and 1.97(b), applicants bring to the attention of the Examiner the documents listed on the attached Form PTO 1449, and respectfully request that the listed documents be considered by the Examiner and made of record in the above-captioned application. Copies of the United States patent references listed on the Form PTO-1449 are not enclosed, but the PCT, foreign and non-patent references are enclosed.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that the listed documents are material or constitute "prior art." If the Examiner applies the documents as prior art against any claim in the

application and applicants determine that the cited documents do not constitute "prior art" under United States law, applicants reserve the right to present to the Office the relevant facts and law regarding the appropriate status of the documents.

Applicants further reserve the right to take appropriate action to establish the patentability of the disclosed invention over the listed documents, should the documents be applied against the claims of the present application.

This submission is being filed before any action by the U.S. Patent and Trademark Office on the merits. Therefore, applicants do not believe that any fee is due in connection with the submission of this paper. However, if any fee is due, or if any overpayment has been made, the Commissioner is authorized to charge any such fee or credit any overpayment, to our Deposit Account No. 50-2054.

Respectfully submitted,

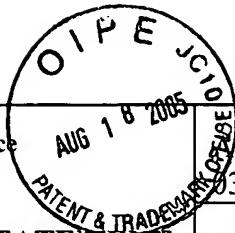
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4847-0377-1392\1

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Johannes F. de Boer

Filing Date
July 9, 2004

Group
2587

U.S. PATENT DOCUMENTS

*Exam. Init.		Document No.							Date	Name	Class	Subclass	Filing Date if Appropriate
		6	6	8	5	8	8	5	February 3, 2004	Nolte et al.			
		6	6	8	7	0	0	7	February 3, 2004	Meigs			
2003	0	0	2	6	7	3	5		February 6, 2003	Nolte et al.			
2004	0	1	6	6	5	9	3		August 26, 2004	Nolte et al.			

FOREIGN PATENT DOCUMENT

		Document No.							Date	Country	Class	SubClass	Translator Yes No
	0	3	0	2	0	1	1	9	March 13, 2003	WIPO			

OTHER DOCUMENTS (including Author, Title Date, Pertinent Pages, Etc.)

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